

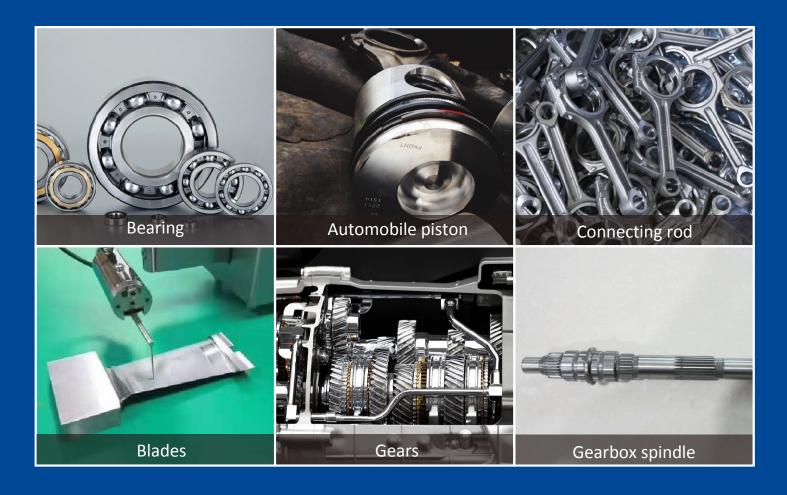


# LeebS480 Surface Roughness Tester

Measure the Roughness / Waviness Carried standards ISO, DIN, JIS, ANSI

Equipped with Industrial PAD
Wired connection or WIFI connection available

## **Application Cases**



It is suitable for measuring all high-precision mechanical production or processing processes

**Application industry** 



#### **Product Briefing**

LeebS480 roughness tester is a product that fully conforms to the latest ISO, DIN, JIS, ANSI international standards. It is a multi-purpose portable instrument for evaluating the surface quality of parts. It has multiple parameters that meet multiple national standards and international standards. It can evaluate the surface roughness, waviness and primary profile of various parts. It can measure the plane, outer cylinder surface, inner hole surface and bearing channel. The surface roughness meter has the characteristics of large measurement range, stable performance and high accuracy. It is suitable for production site, scientific research laboratory and enterprise measurement room. According to the selected measurement conditions, the corresponding parameters are calculated. The measurement results can be displayed digitally and graphically on the LCD touch screen industrial pad. The instrument calculates the parameters on the two profiles of filter profile and direct profile.

The instrument can also be connected to the computer and printer. The special analysis software can directly control the measurement operation and provide powerful analysis functions.

#### **Product Features**

- The scratch depth can be measured
- 1000μm large measurement range inductive sensor ( 2000μm available)
- It is for measuring Roughness profile, Waviness profile, Primary profile, Abbott curve and Motif
- There are two measurement methods with guide head
   and without guide head
- The sensor and the host are connected through the sensor lifting frame, and the height of the sensor can be adjusted without the aid of a platform
- ◆ Chinese / English language can be selected



Hub bearing unit measurement





**Cooling radiator** 

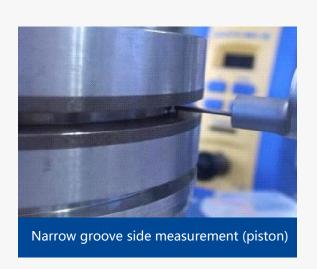


Engine cylinder cover





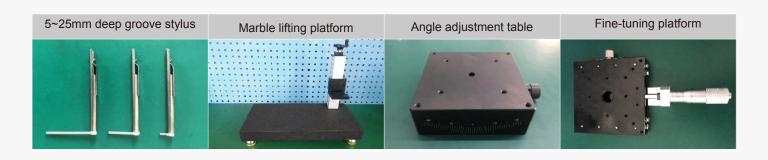
Concave R angle Measurement



## Standard Configuration

Name	Specification	Remarks	Quantity
Host	Stroke 50mm		1
Sensor	Measuring range 1000µm		1
Standard Stylus	5mm		1
Standard Test Block			1
Industrial Pad	10 inches		1
Pad Charger			1
Host charger			1
Connection Cable	2m		1
Certificate			1
Manual			1
Warranty Card			1
Instrument Box			1
Tools			1set

### Optional Accessories



Profile  Pc, Rλa, Rλq, Ir, RSm, Rz94, RPc, RS, Rz,I, Rpm, HSC  Waviness Profile  Primary Parameter  Parameter  Politic Rsk, Rku, Rmax, Sm, Δa, Δq, Rz, λa, λq, Ir, TILT A, AVH, Hmax, Hmin, AREA Rz,J, Pa, Pq, Psk, Pku, Pp, Pv, Pc,I, Pt, PSm, PΔq, PPc, Pc  Abbott Curve  Abott Curve  NCRX, AR, R, Rx, NR, CPM, SR, SAR, AW, W, Wx, Wte, NW, SW, SAW, Rke, Rpke, Rvke, Mr1, Mr2, V0, K  Evaluation curve  Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif  Characteristic curve  Form remove  Filter type  As  O, 2.5, 8, 25μm  λ6  O, 8, 2.5, 8, 25mm	Technical Specifications					
Z direction   1000μm ( 2000μm is available	Model		LeebS480			
Z direction   1000µm ( 2000µm is available)	Range _	X direction	50mm			
Driver   Straightness   1μm/50mm			1000μm ( 2000μm is available)			
Roughness   Profile   Ray	Resolution	X direction	0.0016μm/±50μm -0.016μm/±500μm			
Roughness Profile Roughness Profile Ra75, Rq, Rp, Rv, Rc, Rt, S, R3z, PPI, Ra, Rsk, Rku, Ry, Sm, R∆a, R∆q, Rz Pc, Rλa, Rλq, Ir, R5m, R294, RPc, RS, Rz.I., Rpm, H5C Waviness Profile Perimary Profile Rsk, Rku, Rmax, Sm, ∆a, ∆q, Rz, λa, λq, Ir, TILTA, AVH, Hmax, Hmin, AREA Rz.J., Pa, Pq, Psk, Pku, Pp, Pv, Pc.I. Pt, P5m, P∆q, PPc, Pc Rk, Rpk, Rvk, Mr1, Mr2, V0, K, A1, A2  Motif NCRX, AR, R, Rx, NR, CPM, SR, SAR, AW, W, Wx, Wte, NW, SW, SAW, Rke, Rpke, Rvke, Mr1, Mr2, V0, K  Evaluation curve Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif Characteristic curve Form remove Filter type Gaussian, FFT, PC, DP, 2RC  A\$ Q, 2.5, 8, 25mm  Evaluation length Sampling length × number of samples (sampling length has standard mode and custom m Measurement speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  Ra75, Rq, Rp, Rvk, Rt, S, R3z, Ry, Rpk, Rsk, Rku, Ry, Sm, R∆a, RAQ, Rz, Rz, Rz, Rz, Rz, Rz, Rz, Rz, Rz, Rz	Driver	Straightness	1μm/50mm			
Profile Pc, Rλa, Rλq, Ir, RSm, R294, RPc, RS, Rz.I, Rpm, HSC  Waviness Profile Waviness Profile  Technical Parameter  Primary Profile  Rsk, Rku, Rmax, Sm, Δa, Δq, Rz, λa, λq, Ir, TILT A, AVH, Hmax, Hmin, ARE/Rz.J, Pa, Pq, Psk, Pku, Pp, Pv, Pc.I, Pt, P5m, PΔq, PPc, Pc  Rk, Rpk, Rvk, Mr1, Mr2, V0, K, A1, A2  Motif  NCRX, AR, R, Rx, NR, CPM, SR, SAR, AW, W, Wx, Wte, NW, SW, SAW, Rke, Rpke, Rvke, Mr1, Mr2, V0, K  Evaluation curve  Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif  Characteristic curve  Form remove Form remove Filter type  Gaussian, FFT, PC, DP, 2RC  Als  O, 2.5, 8, 25μm  Af  O, 8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m Measurement speed  O, 0.5mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  ±500μm (±1000μm is available)  Stylus  Stylus  Stylus  Spins diamond 90°	Carried Standards					
VeXINNESS Profile         WCM, WC-Sm, WC-t, Wa, Wq, Wsk, Wku, Wp, Wv, Wz, Wc, Wt, WSm, WΔ WPc           Technical Parameter         Primary Profile         Rsk, Rku, Rmax, Sm, Δa, Δq, Rz, λa, λq, Ir, TILTA, AVH, Hmax, Hmin, AREA Rz, Rx, Rx, Rx, Rx, Rx, Rx, Rx, Rx, Rx, Rx			Ra75、Rq、Rp、Rv、Rc、Rt、S、R3z、PPI、Ra、Rsk、Rku、Ry、Sm、RΔa、RΔq、Rz、 Pc、Rλa、Rλq、Ir、RSm、Rz94、RPc、RS、Rz.I、Rpm、HSC			
Parameter Primary Profile  Rsk, Rku, Rmax, Sm, Δa, Δq, Rz, λa, λq, Ir, TILTA, AVH, Hmax, Hmin, ARE/RzJ, Pa, Pq, Psk, Pku, Pp, Pv, Pc.I, Pt, P5m, PΔq, PPc, Pc  Rk, Rpk, Rvk, Mr1, Mr2, V0, K, A1, A2  Motif  NCRX, AR, R, Rx, NR, CPM, SR, SAR, AW, W, Wx, Wte, NW, SW, SAW, Rke, Rpke, Rvke, Mr1, Mr2, V0, K  Evaluation curve  Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif  Characteristic curve  Abbott curve (Rmr(c), Rmr2(c), Rδc(c), tp(c), tp2(c), Htp(c), Amplitude frequency analysis curve, amplitude distribution curve  Form remove  Filter type  Gaussian, FFT, PC, DP, 2RC  Δs  0, 2.5, 8, 25μm  λc  λf  0.8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m Measurement speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  Nodel  Standard type  Method  Differential inductance  Stylus  Stylus  5μmR diamond 90°	Toobnicol		WCM、WC-Sm、WC-t、Wa、Wq、Wsk、Wku、Wp、Wv、Wz、Wc、Wt、WSm、W $\Delta$ q、			
Abbott Curve         Motif       NCRX, AR, R, Rx, NR, CPM, SR, SAR, AW, W, Wx, Wte, NW, SW, SAW, Rke, Rpke, Ryke, Ryke, Ryke, Mr1, Mr2, V0, K         Evaluation curve       Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif         Characteristic curve       Abbott curve (Rmr(c), Rmr2(c), Rδc(c), tp(c), tp2(c), tp2(c), Amplitude frequency analysis curve, amplitude distribution curve         Form remove       global, first half, second half, center, 2 points, curve         Filter type       Gaussian, FFT, PC, DP, 2RC         AS       0, 2.5, 8, 25μm         Af       0.8, 2.5, 8, 25mm         Evaluation length       Sampling length × number of samples (sampling length has standard mode and custom m         Measurement speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Return speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Model       Standard type         Method       Differential inductance         Sensor       Range       ±500μm (±1000μm is available)         Stylus       5μmR diamond 90°			Rsk、Rku、Rmax、Sm、Δa、Δq、Rz、λa、λq、Ir、TILT A、AVH、Hmax、Hmin、AREA、 Rz.J、Pa、Pq、Psk、Pku、Pp、Pv、Pc.I、Pt、PSm、PΔq、PPc、Pc			
Rke, Rpke, Rvke, Mr1, Mr2, V0, K  Evaluation curve  Roughness profile, Waviness profile, Primary profile, Abbott curve, Motif  Characteristic curve  Abbott curve (Rmr(c), Rmr2(c), R&c(c), tp(c), tp2(c), Htp(c), Amplitude frequency analysis curve, amplitude distribution curve  Form remove  Form remove  Filter type  Gaussian, FFT, PC, DP, 2RC  As  O, 2.5, 8, 25µm  Ac  O, 0.8, 0.25, 0.8, 2.5, 8mm  Af  O.8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m Measurement speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  \$\$tylus\$  \$\$500µm (\$\pm\$ 1000µm is available)  \$\$5µmR diamond 90°		Abbott Curve	Rk、Rpk、Rvk、Mr1、Mr2、V0、K、A1、A2			
Characteristic curve       Abbott curve (Rmr(c) , Rmr2(c) , Rδc(c) , tp(c) , tp2(c) , Htp(c) , Amplitude frequency analysis curve , amplitude distribution curve         Form remove       global, first half, second half, center, 2 points, curve         Filter type       Gaussian, FFT, PC, DP, 2RC         Na       0.2.5, 8, 25μm         Ac       0.08, 0.25, 0.8, 2.5, 8mm         Af       Sampling length × number of samples (sampling length has standard mode and custom m         Measurement speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Return speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Model       Standard type         Method       Differential inductance         Stylus       5μmR diamond 90°		Motif				
Form remove  Form remove  Filter type  As  Gaussian, FFT, PC, DP, 2RC  O, 2.5, 8, 25µm  As  Filtering wavelength  Ac  Af  O.8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m  Measurement speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  Sensor  Range  Stylus  Stylus  SymR diamond 90°	Evaluation curve		Roughness profile、Waviness profile、Primary profile、Abbott curve、Motif			
Filter type  As  O, 2.5, 8, 25µm  O.08, 0.25, 0.8, 2.5, 8mm  Af  O.8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m  Measurement speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  O.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  ±500µm ( ± 1000µm is available)  Stylus  Sylus  Sylus	Characteristic curve					
Filtering wavelength  Ac  0, 2.5, 8, 25µm  0.08, 0.25, 0.8, 2.5, 8mm  Af  0.8, 2.5, 8, 25mm  Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m  Measurement speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  Sensor  Range  Stylus  5µmR diamond 90°	Form remove		global, first half, second half, center, 2 points, curve			
Filtering wavelength       λC       0.08, 0.25, 0.8, 2.5, 8mm         Evaluation length       Sampling length × number of samples (sampling length has standard mode and custom m         Measurement speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Return speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Model       Standard type         Method       Differential inductance         Sensor       Range       ±500μm (± 1000μm is available)         Stylus       5μmR diamond 90°			Gaussian、FFT、PC、DP、2RC			
λf       0.8、2.5、8、25mm         Evaluation length       Sampling length × number of samples (sampling length has standard mode and custom m         Measurement speed       0.05mm/s、0.10mm/s、0.50mm/s、1.00mm/s、2.00mm/s         Return speed       0.05mm/s、0.10mm/s、0.50mm/s、1.00mm/s、2.00mm/s         Model       Standard type         Method       Differential inductance         Sensor       Range         ±500μm (±1000μm is available)         Stylus       5μmR diamond 90°		λs	0、2.5、8、25μm			
Evaluation length  Sampling length × number of samples (sampling length has standard mode and custom m  Measurement speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Return speed  0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s  Model  Standard type  Method  Differential inductance  ±500μm ( ± 1000μm is available)  Stylus  5μmR diamond 90°			0.08、0.25、0.8、2.5、8mm			
Measurement speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Return speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Model       Standard type         Method       Differential inductance         Sensor       Range       ±500μm (± 1000μm is available)         Stylus       5μmR diamond 90°		λf	0.8、	0.8、2.5、8、25mm		
Return speed       0.05mm/s, 0.10mm/s, 0.50mm/s, 1.00mm/s, 2.00mm/s         Model       Standard type         Method       Differential inductance         Sensor       Range       ±500μm (± 1000μm is available)         Stylus       5μmR diamond 90°	Evaluation length		Sampling length × number of samples (sampling length has standard mode and custom mode)			
Model       Standard type         Method       Differential inductance         Sensor       Range       ±500μm (±1000μm is available)         Stylus       5μmR diamond 90°	Measurement speed		0.05mm/s、 0.10mm/s、 0.50mm/s、 1.00mm/s、 2.00mm/s			
Method  Differential inductance  Especial Experiments of the state of	Return speed		0.05mm/s、 0.10mm/s、 0.50mm/s、 1.00mm/s、 2.00mm/s			
Sensor Range ±500μm ( ± 1000μm is available)  Stylus 5μmR diamond 90°		Model	el Standard type			
Stylus 5μmR diamond 90°		Method	Differential inductance			
Force	Sensor	Range	±500μm ( ± 1000μm is available)			
Force 7.5mn Adjustable		Stylus		5μmR diamond 90°		
		Force	7.51			
Display part 10-inch color IPS touch screen		Display part				
Operator Data output TF card/U disk/WIFI printing/PDF file	Operator (Pad)					
(Pad)  Language  Chinese/English		<u> </u>				
	Power Supply					
Power Consumption About 30VA (800 times can be measured after fully charged)						
Dimension  Host Body 80(W)*392(L)*180(H) Industrial Pad 245(W)*162(L)*68(H)  Net weight 4Kg Gross Weight 8Kg			Host Body 80(W)*392(L)*180(H)			